# IDWD30G120C5



# 5<sup>th</sup> Generation CoolSiC<sup>™</sup> 1200V Schottky Diode

## SiC Diode

### Features

- No reverse recovery current / no forward recovery
- High surge current capability
- Temperature independent switching behaviour
- Low forward voltage even at high operating temperature
- Tight forward voltage distribution
- Specified dv/dt ruggedness
- Pb-free lead plating; RoHS compliant

## **Potential applications**

- Industrial power supplies: Industrial UPS
- Infrastructure-Charge: Charger
- Metal treatment: Welding
- Solar central inverters, Solar string inverter and Solar optimizer

## **Product validation**

Qualified for industrial applications according to the relevant tests of JEDEC 47/20/22

## Description

- System efficiency improvement over Si diodes
- Enabling higher frequency / increased power density solutions
- System size/cost savings due to reduced heatsink requirements and smaller magnetics
- Reduced EMI
- Highest efficiency across the entire load range
- Robust diode operation during surge events
- High reliability
- Related Links: <u>www.infineon.com/SiC</u>

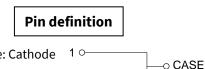






Туре	V <sub>DC</sub>	IF	Qc	T <sub>vj,max</sub>	Marking	Package
IDWD30G120C5	1200 V	30 A	154nC	175°C	D3012C5	PG-T0247-2





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Pin 1 and backside: Cathode

Pin 2: Anode

#### Datasheet www.infineon.com Downloaded from Arrow.com.



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**Maximum ratings** 

# **1** Maximum ratings

Note:

For optimum lifetime and reliability, Infineon recommends operating conditions that do not exceed 80% of the maximum ratings stated in this datasheet.

Parameter	Symbol	Value	Unit
Repetitive peak reverse voltage $T_{\rm C} \ge 25^{\circ}{\rm C}$	V <sub>RRM</sub>	1200	V
Continuous forward current for $R_{th(j-c,max)}$ $T_c = 156^{\circ}C, D=1$ $T_c = 135^{\circ}C, D=1$ $T_c = 25^{\circ}C, D=1$	1 <sub>F</sub>	30 40 87	A
Surge repetitive forward current, sine halfwave <sup>1</sup> $T_c=25$ °C, t <sub>p</sub> =10ms $T_c=100$ °C, t <sub>p</sub> =10ms	I <sub>F,RM</sub>	120 90	A
Surge non-repetitive forward current, sine halfwave $T_c=25^{\circ}C$ , $t_p=10ms$ $T_c=150^{\circ}C$ , $t_p=10ms$	J <sub>F,SM</sub>	240 230	A
Non-repetitive peak forward current $T_c = 25^{\circ}C, t_p=10 \ \mu s$	I <sub>F,max</sub>	2460	А
i <sup>2</sup> t value $T_{c} = 25^{\circ}C, t_{p}=10 \text{ ms}$ $T_{c} = 150^{\circ}C, t_{p}=10 \text{ ms}$	∫i²dt	288 264	A <sup>2</sup> s
Diode dv/dt ruggedness V <sub>R</sub> =0960 V	dv/dt	150	V/ns
Power dissipation for $R_{th(j-c,max)}$ $T_c = 25^{\circ}C$	P <sub>tot</sub>	332	W

 <sup>&</sup>lt;sup>1</sup> Not subject to production test. The test was performed with 20000 pulses (two consecutive half-wave rectified sines with 10 ms period).
Datasheet Please read the Important Notice and Warnings at the end of this document V 2.

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### Maximum ratings

Operating temperature	T <sub>vj</sub>	-55175	°C
Storage temperature	$T_{\rm stg}$	-55150	°C
Soldering temperature, wave soldering only allowed at leads 1.6mm (0.063 in.) from case for 10 s	T <sub>sold</sub>	260	°C
Mounting torque, M3 screw Maximum of mounting processes: 3	М	0.6	Nm



Thermal resistances

#### **Thermal resistances** 2

Parameter	Cumhal	Conditions	Value			Unit
Parameter	Symbol		min.	typ.	max.	Unit
Characteristic						
Diode thermal resistance, junction – case	R <sub>th(j-c)</sub>		-	0.35	0.5	K/W
Thermal resistance, junction – ambient	$R_{th(j-a)}$	leaded	-	-	62	K/W



**Electrical Characteristics** 

#### **Electrical Characteristics** 3

### Static Characteristics, at $T_{vj}$ =25°C, unless otherwise specified

Parameter	Symbol	Conditions	Value			Unit
Parameter			min.	typ.	max.	Unit
DC blocking voltage	V <sub>DC</sub>	<i>T<sub>vj</sub></i> = 25°C, I <sub>R</sub> =500μA	1200	-	-	V
Diode forward voltage	V <sub>F</sub>	<i>I</i> <sub>F</sub> = 30A, <i>T</i> <sub>vj</sub> =25°C	-	1.4	1.65	V
		<i>I</i> <sub>F</sub> = 30A, <i>T</i> <sub>vj</sub> =150°C	-	1.7	-	
Reverse current	I <sub>R</sub>	V <sub>R</sub> =1200V, <i>T<sub>vj</sub></i> =25°C	-	17	248	μΑ
		<i>V</i> <sub>R</sub> =1200V, <i>T</i> <sub>vj</sub> =150°C	-	88	-	

### Dynamic Characteristics, at $T_{\nu j}$ =25°C, unless otherwise specified

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	Ome
Total capacitive charge		<i>V</i> <sub>R</sub> = 800V, <i>T</i> <sub>vj</sub> =150°C & 25°C				
	Qc	$Q_C = \int_0^{V_R} C(V) dV$	-	154	-	nC
		<i>V</i> <sub>R</sub> =1 V, <i>f</i> =1 MHz	-	1980	-	
Total Capacitance	С	<i>V</i> <sub>R</sub> =400 V, <i>f</i> =1 MHz	-	140	-	pF
		<i>V</i> <sub>R</sub> =800 V, <i>f</i> =1 MHz	-	111	-	

5<sup>th</sup> Generation CoolSiC<sup>™</sup> 1200V Schottky Diode SiC Diode Electrical Characteristics Diagrams



4 Electrical Characteristics Diagrams

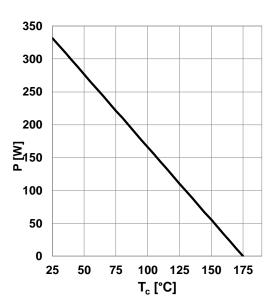


Figure 1. Power dissipation as function of case temperature,  $P_{tot}$ =f(TC),  $R_{th(j-c),max}$ 

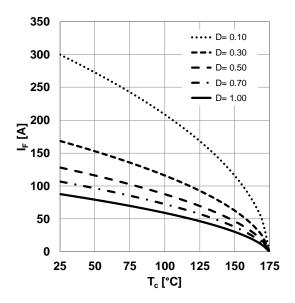


Figure 2. Diode forward current as function of temperature, parameter:  $T_{\nu j} \leq 175^{\circ}$ C, R<sub>th(j.</sub> c),max, D=duty cycle, V<sub>th</sub>, R<sub>diff</sub> @  $T_{\nu j} = 175^{\circ}$ C

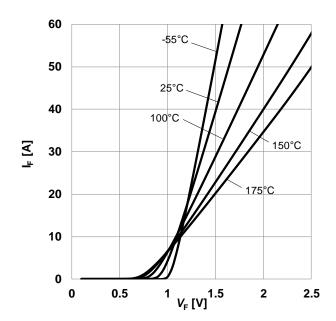


Figure 3. Typical forward characteristics,  $I_F=f(V_F)$ ,  $t_p=10 \mu s$ , parameter:  $T_{vj}$ 

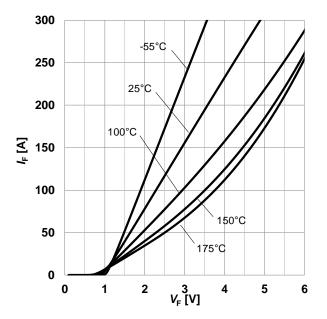
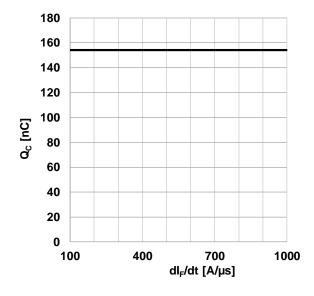


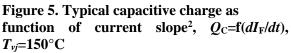
Figure 4. Typical forward characteristics in surge current,  $I_F=f(V_F)$ ,  $t_p=10 \ \mu s$ , parameter:  $T_{vj}$ 

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### **Electrical Characteristics Diagrams**





2) guaranteed by design

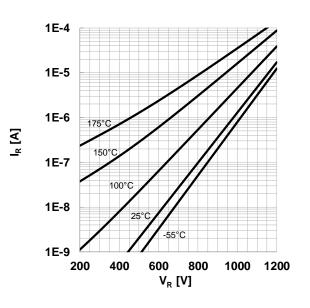


Figure 6. Typical reverse characteristics,  $I_R=f(V_R)$ , parameter:  $T_{\nu j}$ 

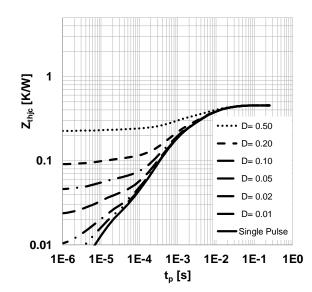


Figure 7. Max. transient thermal impedance, Z<sub>th,j-c</sub>=f(tP), parameter: D=tP/T

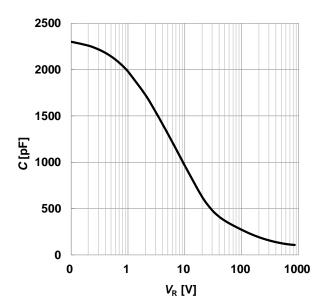


Figure 8. Typical capacitance as function of reverse voltage, C=f(VR); T<sub>vj</sub>=25°C; f=1 MHz

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### **Electrical Characteristics Diagrams**

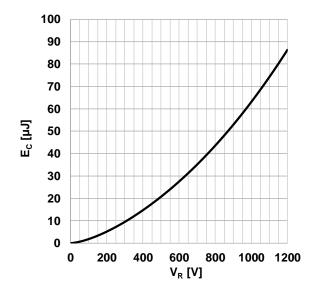
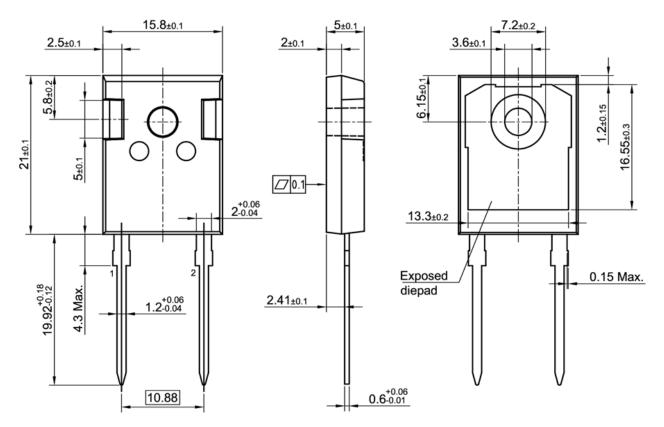


Figure 9. Typical capacitively stored energy as function of reverse voltage,  $E_{\rm C}=f(V_{\rm R})$ 



# 5 Package Drawing

# PG-TO247-2



# 5<sup>th</sup> Generation CoolSiC<sup>™</sup> 1200V Schottky Diode SiC-Diode Revision history



# **Revision history**

Document version	Date of release	Description of changes
V 1.0	2018-12-21	Preliminary Datasheet
V 2.0	2019-01-30	Final Datasheet
V 2.1	2021-03-01	Increased dv/dt ruggedness

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**Document reference** 

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